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1	NFORM	ATION DISCLO			APPLICANT M. OKAMOTO ET AL.				
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			U	.S. PATENT D	OCUMENTS				
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777	US	5,578,241		1996-11-26	Plach et al.	<u> </u>		ļ	
78		6,327,010		2001-12-04	Scheuble et al.	<del>                                     </del>			
+12	<u> </u>	6,195,140		2001-02-27	Kubo et al.	<u> </u>			
<del>- + /</del>	I	5,598,285		1997-01-28	Kondo et al.	<b></b>	-		
40		5,737,051		1998-04-07	Kondo et al.	<u> </u>	-		
4	I	5,220,444		1993-06-15	Mitsui, et al.	<del> </del>			
47	<u> </u>	5,691,791		1997-11-25	Nakamura et al.			<b>-</b>	
- <del>1</del> 0	i	US 5,684,551		1997-11-04	Nakamura et al.	<del></del>			
+4		5,847,789		1998-12-08	Nakamura et al.	<b></b>			
47	1	US 6,108,064		2000-08-01	Minoura, et al.	<u> </u>	<del> </del>		٠
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		NUMBER					CLASS	YE5 ·	, NO
TD	JP	59218483		1984-12-08	Japan			Х	
TD	JP	07318929		1995-12-08	Japan			Х	,
T		9848320		1998-10-29	WIPO			Х	
Th		11-101992		1999-04-13	JAPAN			X	
T		07-333598		1995-12-22	JAPAN			Х	
tó		09-274327		1997-10-21	JAPAN			Х	
70	JP	10-282488		1998-10-23	JAPAN			X*	
TO	JP	10-325953		1998-12-08	JAPAN			Х*	
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to	JP	11-183892		1999-07-09	JAPAN			X*	
TD		JP 11-52366	A	1999-02-26	JAPAN			ABS	
		7-318929	A	1995-12-08	JAPAN			ABS	
TD	<del></del>		A	1995-12-22	JAPAN			ABS	
TD TD		7-333598							
		08-292413		1996-11-05	JAPAN		•	ABS	
TD	JP	•	A	1996-11-05 1984-01-28	JAPAN JAPAN			ABS	

TD	JP	07-114020	Α.	1995-05-02	JAPAN	XX	X
71)	JP	03-245122	A	1991-10-31	JAPAN	XX	X
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T					n," J.C. Stevens et . pp. 375-385 (Mar.		the
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TO	US	6,147,728	1	2000-11-14	Okumura et al	-				
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TD		61-230101		1986-10-14	JAPAN			Abs		
OT		07-218923		1995-08-18	JAPAN			Abs		
TD		10-142621		1998-05-29	JAPAN			Abs		
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